

Description

The **vs11n03-s8** uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.It is ESD protested.

General Features

V_{DS} = 30V,I_D =11A

 $R_{DS(ON)}$ < 10m Ω @ V_{GS} =10V

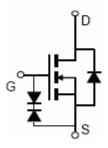
 $R_{DS(ON)}$ < 14m Ω @ V_{GS} =4.5V

ESD Rating: 2000V HBM

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

Application

- ●PWM application
- ●Load switch



Schematic diagram



Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VS11N03-S8	VS11N03-S8	SOP-8	Ø330mm	12mm	

Absolute Maximum Ratings (T_A=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	VDS	30	V	
Gate-Source Voltage	V _G S	±10	V	
Drain Current-Continuous	I _D	11	A	
Drain Current-Pulsed (Note 1)	I _{DM}	50	Α	
Maximum Power Dissipation	P _D	2.5	W	
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}$ C	

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	R _{0JA}	50	°C/W



Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	30		-	V
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} =30 V , V_{GS} =0 V	-	-	1	μA
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Gate-Body Leakage Current	I _{GSS}	V_{GS} =±10 V , V_{DS} =0 V	=	-	±10	μA
On Characteristics (Note 3)			'			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.0	1.5	2.0	V
One in Course On Otata Busintan	-	V_{GS} =10V, I_D =8A	-	7	10	mΩ
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =6A	-	10	14	mΩ
Forward Transconductance	g FS	V _{DS} =10V,I _D =11A	25	-	=	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	V _{DS} =15V,V _{GS} =0V, F=1.0MHz	-	1155	-	PF
Output Capacitance	C _{oss}		-	260	-	PF
Reverse Transfer Capacitance	C _{rss}		-	95	-	PF
Switching Characteristics (Note 4)			'			
Turn-on Delay Time	t _{d(on)}		-	10		nS
Turn-on Rise Time	t _r	V _{DD} =15V,R _L =2.2Ω	-	16		nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =5 V , R_{GEN} =3 Ω	-	40		nS
Turn-Off Fall Time	t _f		-	10.8		nS
Total Gate Charge	Qg	V _{DS} =15V,I _D =8A,	-	17.5		nC
Gate-Source Charge	Q _{gs}		-	4.5	-	nC
Gate-Drain Charge	Q_{gd}	V_{GS} =4.5 V	-	2.5	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =1A	-	x	1.2	V
Diode Forward Current (Note 2)	Is		_	-	11	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics

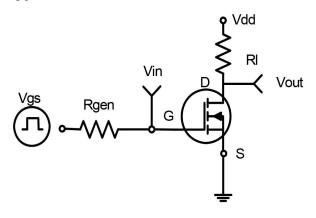


Figure 1:Switching Test Circuit

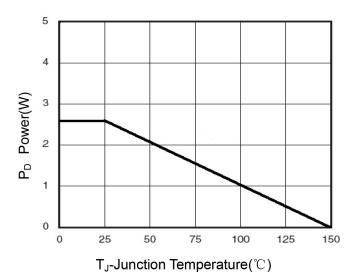


Figure 3 Power Dissipation

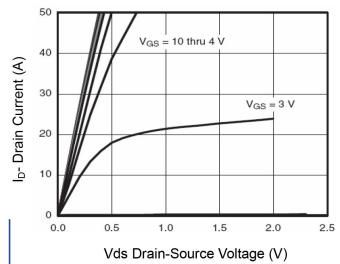


Figure 5 Output Characteristics

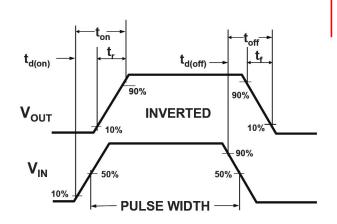


Figure 2:Switching Waveforms

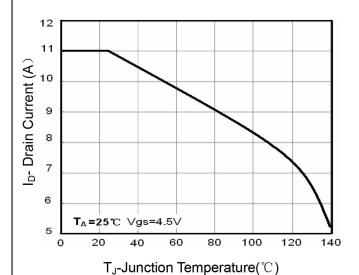


Figure 4 Drain Current

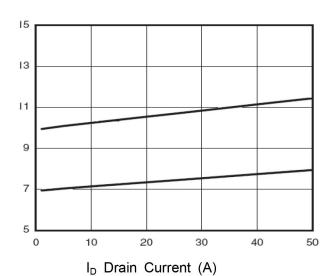


Figure 6 Drain-Source On-Resistance

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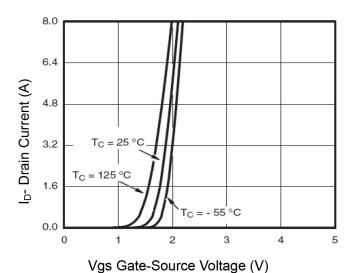
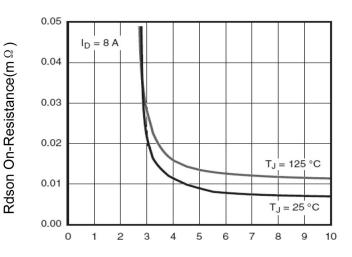
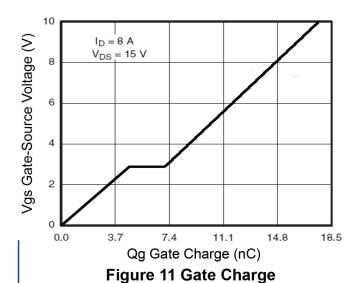


Figure 7 Transfer Characteristics



Vgs Gate-Source Voltage (V)
Figure 9 Rdson vs Vgs



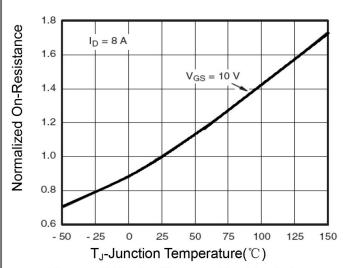


Figure 8 Drain-Source On-Resistance

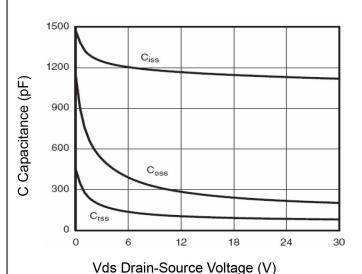
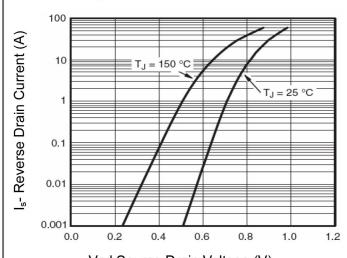


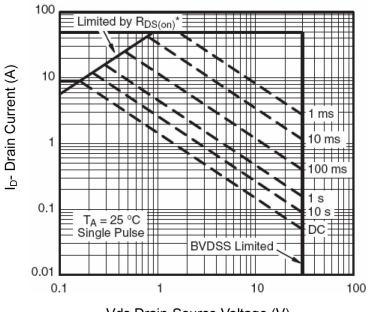
Figure 10 Capacitance vs Vds



Vsd Source-Drain Voltage (V)
Figure 12 Source- Drain Diode Forward

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Vds Drain-Source Voltage (V)

Figure 13 Safe Operation Area

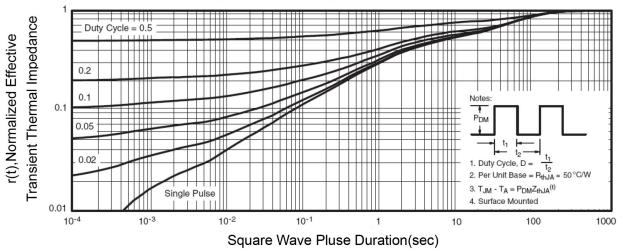


Figure 14 Normalized Maximum Transient Thermal Impedance